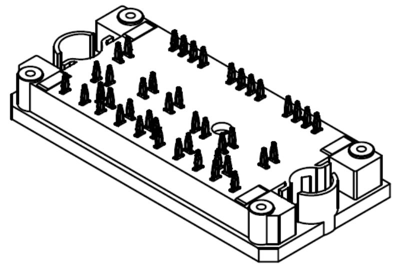
Q1 3-Phase TNPC Module

NXH25T120L2Q1PG

The NXH25T120L2Q1PG/PTG is a case power module containing a three channel T−type neutral−point clamped (TNPC) circuit. Each channel has a two 1200 V, 25 A IGBTs with inverse diodes and two 650 V, 20 A IGBTs with inverse diodes. The module contains an NTC thermistor.



Q1 3−TNPC
PRESS FIT
CASE 180AS

Features

- Low Package Height
- Compact 82.5 mm x 37.4 mm x 12 mm Package
- Press−fit Pins
- Options with Pre−applied Thermal Interface Material (TIM) and Without Pre−applied TIM
- Thermistor

Typical Applications

- Solar Inverters
- UPS

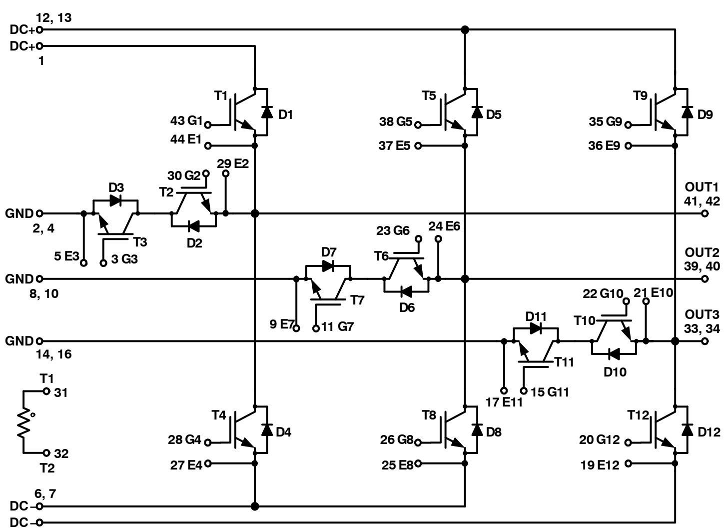
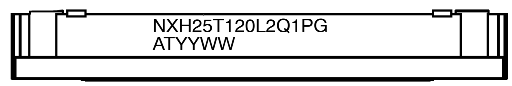
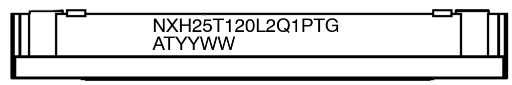


Figure 1. NXH25T120L2Q1PG/PTG Schematic Diagram

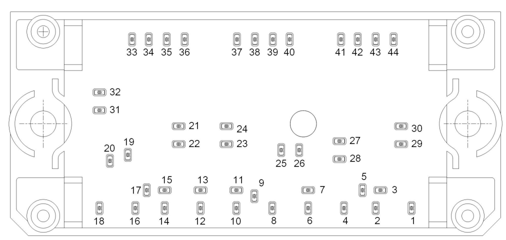
DEVICE MARKING





NXH25T120L2Q1P or NXH25T120L2Q1PT	= Specific Device Code
G	= Pb−Free Package
AT	= Assembly & Test Site Code
YYWW	= Year and Work Week Code

PIN ASSIGNMENTS



ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

NOTE: Some of the devices on this data sheet have been **DISCONTINUED**. Please refer to the table on page 5.

May, 2025 − Rev. 1

Publication Order Number:
NXH25T120L2Q1PG/D

Table 1. MAXIMUM RATINGS (Note 1)

Rating	Symbol	Value	Unit
HALF BRIDGE IGBT			
Collector−Emitter Voltage	V_{CES}	1200	V
Gate−Emitter Voltage	V_{GE}	±20	V
Continuous Collector Current @ T_c = 80°C (T_J = 175°C)	I_C	25	A
Pulsed Collector Current (T_J = 175°C)	I_{Cpulse}	75	A
Maximum Power Dissipation (T_J = 175°C)	P_{tot}	81	W
Short Circuit Withstand Time @ V_{GE} = 15 V, V_{CE} = 600 V, $T_J \leq$ 150°C	T_{sc}	5	μs
Minimum Operating Junction Temperature	T_{JMIN}	−40	°C
Maximum Operating Junction Temperature	T_{JMAX}	150	°C
NEUTRAL POINT IGBT			
Collector−Emitter Voltage	V_{CES}	650	V
Gate−Emitter Voltage	V_{GE}	±20	V
Continuous Collector Current @ T_c = 80°C (T_J = 175°C)	I_C	20	A
Pulsed Collector Current (T_J = 175°C)	I_{Cpulse}	60	A
Maximum Power Dissipation (T_J = 175°C)	P_{tot}	50	W
Short Circuit Withstand Time @ V_{GE} = 15 V, V_{CE} = 400 V, $T_J \leq$ 150°C	T_{sc}	5	μs
Minimum Operating Junction Temperature	T_{JMIN}	−40	°C
Maximum Operating Junction Temperature	T_{JMAX}	150	°C
HALF BRIDGE DIODE			
Peak Repetitive Reverse Voltage	V_{RRM}	1200	V
Continuous Forward Current @ T_c = 80°C (T_J = 175°C)	I_F	15	A
Repetitive Peak Forward Current (T_J = 175°C)	I_{FRM}	45	A
Maximum Power Dissipation (T_J = 175°C)	P_{tot}	43	W
Minimum Operating Junction Temperature	T_{JMIN}	−40	°C
Maximum Operating Junction Temperature	T_{JMAX}	150	°C
NEUTRAL POINT DIODE			
Peak Repetitive Reverse Voltage	V_{RRM}	650	V
Continuous Forward Current @ T_c = 80°C (T_J = 175°C)	I_F	15	A
Repetitive Peak Forward Current (T_J = 175°C)	I_{FRM}	45	A
Maximum Power Dissipation (T_J = 175°C)	P_{tot}	39	W
Minimum Operating Junction Temperature	T_{JMIN}	−40	°C
Maximum Operating Junction Temperature	T_{JMAX}	150	°C
THERMAL PROPERTIES			
Storage Temperature range	T_{stg}	−40 to 125	°C
INSULATION PROPERTIES			
Isolation test voltage, t = 1 sec, 60Hz	V_{is}	3000	V_{RMS}
Creepage distance		12.7	mm

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS, RECOMMENDED OPERATING RANGES and/or APPLICATION INFORMATION for Safe Operating parameters.

Table 2. RECOMMENDED OPERATING RANGES

Rating	Symbol	Min	Max	Unit
Module Operating Junction Temperature	T_J	−40	150	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

Table 3. ELECTRICAL CHARACTERISTICS T_J = 25°C unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
HALF BRIDGE IGBT CHARACTERISTICS						
Collector−Emitter Cutoff Current	V_{GE} = 0 V, V_{CE} = 1200 V	I_{CES}	–	–	300	μA
Collector−Emitter Saturation Voltage	V_{GE} = 15 V, I_C = 25 A, T_J = 25°C	$V_{CE(sat)}$	–	1.90	2.50	V
	V_{GE} = 15 V, I_C = 25 A, T_J = 125°C		–	1.96	–	
Gate−Emitter Threshold Voltage	V_{GE} = V_{CE}, I_C = 1.5 mA	$V_{GE(TH)}$	4.90	5.49	6.50	V
Gate Leakage Current	V_{GE} = 20 V, V_{CE} = 0 V	I_{GES}	–	–	300	nA
Turn−on Delay Time	T_J = 25°C V_{CE} = 350 V, I_C = 15 A V_{GE} = ±15 V, R_G = 15 Ω	$t_{d(on)}$	–	59	–	ns
Rise Time		t_r	–	26	–	
Turn−off Delay Time		$t_{d(off)}$	–	242	–	
Fall Time		t_f	–	52	–	
Turn−on Switching Loss per Pulse		E_{on}	–	220	–	μJ
Turn off Switching Loss per Pulse		E_{off}	–	240	–	
Turn−on Delay Time	T_J = 125°C V_{CE} = 350 V, I_C = 15 A V_{GE} = ±15 V, R_G = 15 Ω	$t_{d(on)}$	–	48	–	ns
Rise Time		t_r	–	29	–	
Turn−off Delay Time		$t_{d(off)}$	–	293	–	
Fall Time		t_f	–	258	–	
Turn−on Switching Loss per Pulse		E_{on}	–	400	–	μJ
Turn off Switching Loss per Pulse		E_{off}	–	710	–	
Input Capacitance	V_{CE} = 20 V, V_{GE} = 0 V. f = 10 kHz	C_{ies}	–	8502	–	pF
Output Capacitance		C_{oes}	–	187	–	
Reverse Transfer Capacitance		C_{res}	–	154	–	
Total Gate Charge	V_{CE} = 600 V, I_C = 25 A, V_{GE} = ±15 V	Q_g	–	352	–	nC
Thermal Resistance − chip−to−heatsink	Thermal grease, Thickness ≤ 2.25 Mil, λ = 2.9 W/mK	R_{thJH}	–	1.17	–	°C/W
NEUTRAL POINT DIODE CHARACTERISTICS						
Diode Forward Voltage	I_F = 15 A, T_J = 25°C	V_F	–	2.43	–	V
	I_F = 15 A, T_J = 125°C		–	1.60	–	
Combined IGBT + Diode Voltage Drop	I_F = 15 A, T_J = 25°C	V_{DT}	–	3.76	4.60	V
Reverse Recovery Time	T_J = 25°C V_{CE} = 350 V, I_C = 15 A V_{GE} = ±15 V, R_G = 15 Ω	t_{rr}	–	59	–	ns
Reverse Recovery Charge		Q_{rr}	–	0.21	–	μC
Peak Reverse Recovery Current		I_{RRM}	–	7	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	106	–	A/μs
Reverse Recovery Energy		E_{rr}	–	40	–	μJ
Reverse Recovery Time	T_J = 125°C V_{CE} = 350 V, I_C = 15 A V_{GE} = ±15 V, R_G = 15 Ω	t_{rr}	–	67	–	ns
Reverse Recovery Charge		Q_{rr}	–	0.69	–	μC
Peak Reverse Recovery Current		I_{RRM}	–	19	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	451	–	A/μs
Reverse Recovery Energy		E_{rr}	–	100	–	μJ
Thermal Resistance − chip−to−heatsink	Thermal grease, Thickness ≤ 2.25 Mil, λ = 2.9 W/mK	R_{thJH}	–	2.45	–	°C/W

Table 3. ELECTRICAL CHARACTERISTICS T_J = 25°C unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
NEUTRAL POINT IGBT CHARACTERISTICS						
Collector−Emitter Cutoff Current	V_{GE} = 0 V, V_{CE} = 650 V	I_{CES}	–	–	200	μA
Collector−Emitter Saturation Voltage	V_{GE} = 15 V, I_C = 20 A, T_J = 25°C	$V_{CE(sat)}$	–	1.49	–	V
	V_{GE} = 15 V, I_C = 20 A, T_J = 125°C		–	1.61	–	
Gate−Emitter Threshold Voltage	V_{GE} = V_{CE}, I_C = 1.65 mA	$V_{GE(TH)}$	4.70	5.68	6.50	V
Gate Leakage Current	V_{GE} = 20 V, V_{CE} = 0 V	I_{GES}	–	–	200	nA
Turn−on Delay Time	T_J = 25°C V_{CE} = 350 V, I_C = 15 A V_{GE} = ±15V, R_G = 15 Ω	$t_{d(on)}$	–	33	–	ns
Rise Time		t_r	–	18	–	
Turn−off Delay Time		$t_{d(off)}$	–	126	–	
Fall Time		t_f	–	43	–	
Turn−on Switching Loss per Pulse		E_{on}	–	250	–	μJ
Turn off Switching Loss per Pulse		E_{off}	–	180	–	
Turn−on Delay Time	T_J = 125°C V_{CE} = 350 V, I_C = 15 A V_{GE} = ±15 V, R_G = 15 Ω	$t_{d(on)}$	–	31	–	ns
Rise Time		t_r	–	19	–	
Turn−off Delay Time		$t_{d(off)}$	–	138	–	
Fall Time		t_f	–	72	–	
Turn−on Switching Loss per Pulse		E_{on}	–	390	–	uJ
Turn off Switching Loss per Pulse		E_{off}	–	300	–	
Input Capacitance	V_{CE} = 20 V, V_{GE} = 0 V, f = 10 kHz	C_{ies}	–	3837	–	pF
Output Capacitance		C_{oes}	–	127	–	
Reverse Transfer Capacitance		C_{res}	–	104	–	
Total Gate Charge	V_{CE} = 480 V, I_C = 20 A, V_{GE} = ±15 V	Q_g	–	166	–	nC
Thermal Resistance − chip−to−heatsink	Thermal grease, Thickness ≤ 2.25 Mil, λ = 2.9 W/mK	R_{thJH}	–	1.90	–	°C/W
HALF BRIDGE DIODE CHARACTERISTICS						
Diode Forward Voltage	I_F = 15 A, T_J = 25°C	V_F	–	2.47	3	V
	I_F = 15 A, T_J = 125°C		–	1.97	–	
Reverse Recovery Time	T_J = 25°C V_{CE} = 350 V, I_C = 15 A V_{GE} = ±15 V, R_G = 15 Ω	t_{rr}	–	63	–	ns
Reverse Recovery Charge		Q_{rr}	–	0.45	–	μC
Peak Reverse Recovery Current		I_{RRM}	–	17	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	313	–	A/μs
Reverse Recovery Energy		E_{rr}	–	70	–	μJ
Reverse Recovery Time	T_J = 125°C V_{CE} = 350 V, I_C = 15 A V_{GE} = ±15 V, R_G = 15 Ω	t_{rr}	–	233	–	ns
Reverse Recovery Charge		Q_{rr}	–	1.55	–	μC
Peak Reverse Recovery Current		I_{RRM}	–	22	–	A
Peak Rate of Fall of Recovery Current		di/dt	–	76	–	A/μs
Reverse Recovery Energy		E_{rr}	–	360	–	μJ
Thermal Resistance − chip−to−heatsink	Thermal grease, Thickness ≤ 2.25 Mil, λ = 2.9 W/mK	R_{thJH}	–	2.21	–	°C/W

Table 3. ELECTRICAL CHARACTERISTICS T_J = 25°C unless otherwise noted

Parameter	Test Conditions	Symbol	Min	Typ	Max	Unit
THERMISTOR CHARACTERISTICS						
Nominal resistance	T = 25°C	R_{25}	–	22	–	kΩ
Nominal resistance	T = 100°C	R_{100}	–	1468	–	Ω
Deviation of R25		ΔR/R	−5		5	%
Power dissipation		P_D	–	200	–	mW
Power dissipation constant			–	2	–	mW/K
B−value	B(25/50), tolerance ±3%		–	3950	–	K
B−value	B(25/100), tolerance ±3%		–	3998	–	K

ORDERING INFORMATION

Orderable Part Number	Marking	Package	Shipping
NXH25T120L2Q1PTG	NXH25T120L2Q1PTG	Q1 3−Phase TNPC – Case 180AS Press−fit Pins with pre−applied thermal interface material (TIM) (Pb – Free)	21 Units / Blister Tray

DISCONTINUED (Note 2)

NXH25T120L2Q1PG	NXH25T120L2Q1PG	Q1 3−Phase TNPC – Case 180AS Press−fit Pins (Pb – Free)	21 Units / Blister Tray

2. **DISCONTINUED:** This device is not recommended for new design. Please contact your **onsemi** representative for information. The most current information on this device may be available on www.onsemi.com.

TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT AND DIODE

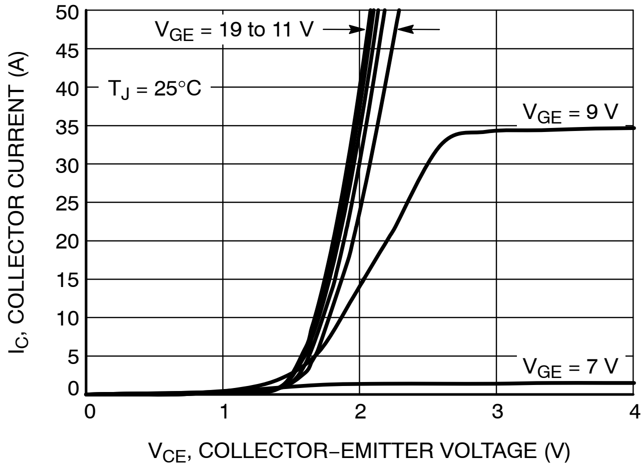


Figure 2. Typical Output Characteristics

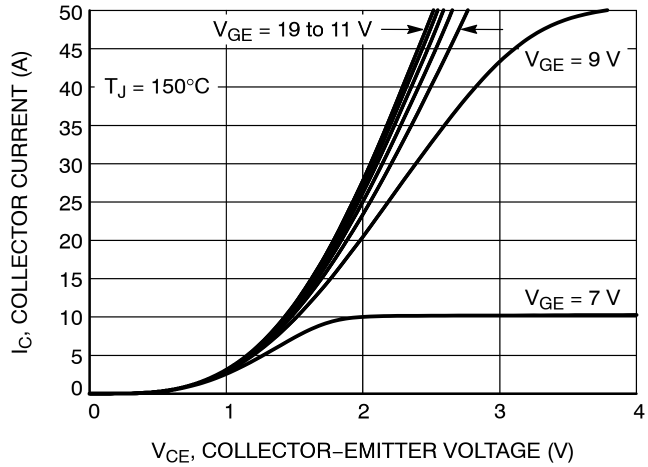


Figure 3. Typical Output Characteristics

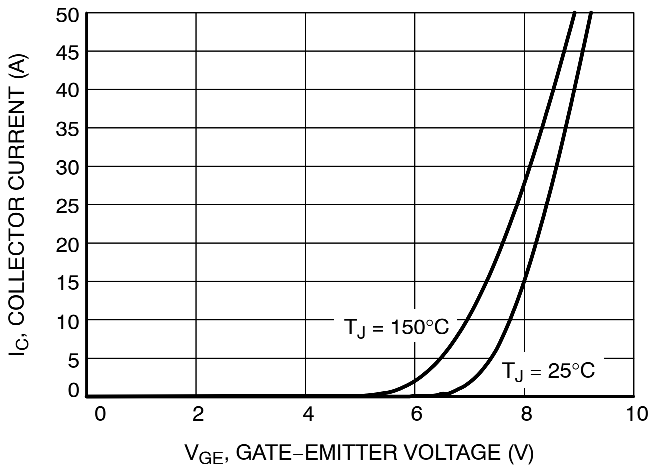


Figure 4. Typical Transfer Characteristics

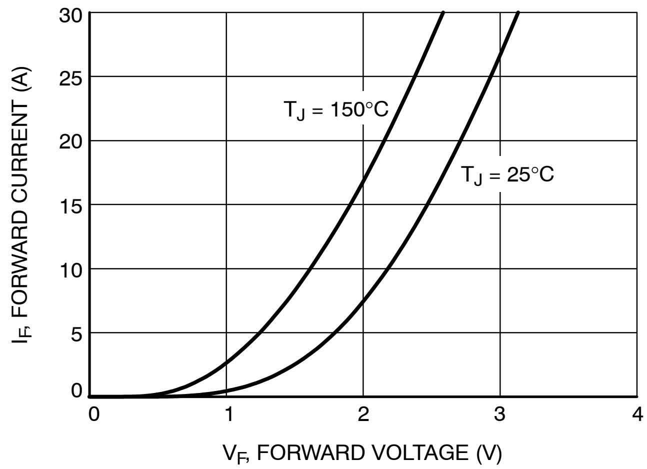


Figure 5. Diode Forward Characteristics

TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT AND DIODE

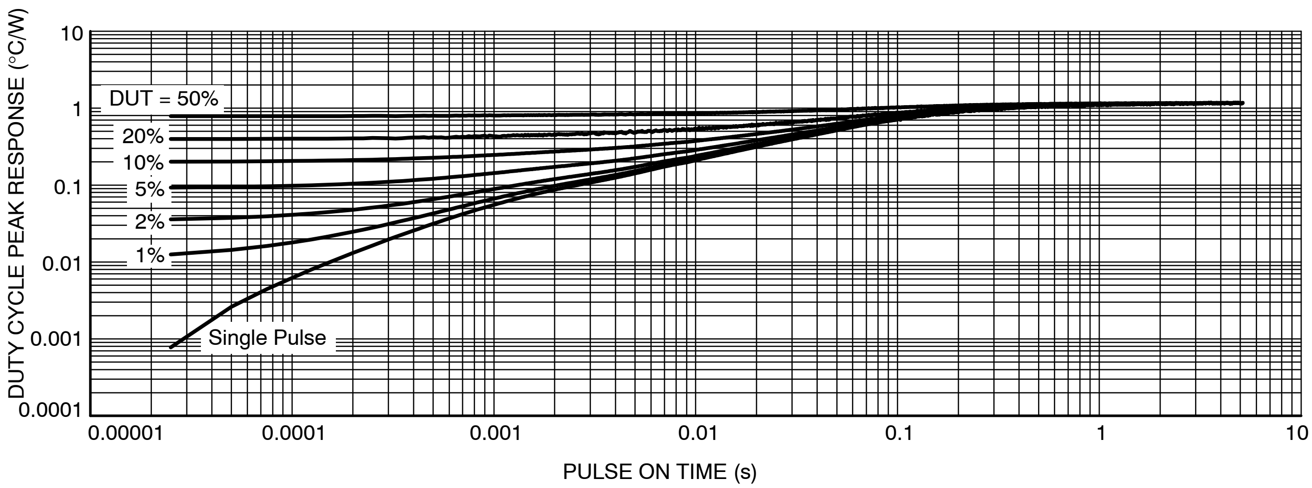


Figure 6. Transient Thermal Impedance (Half Bridge IGBT)

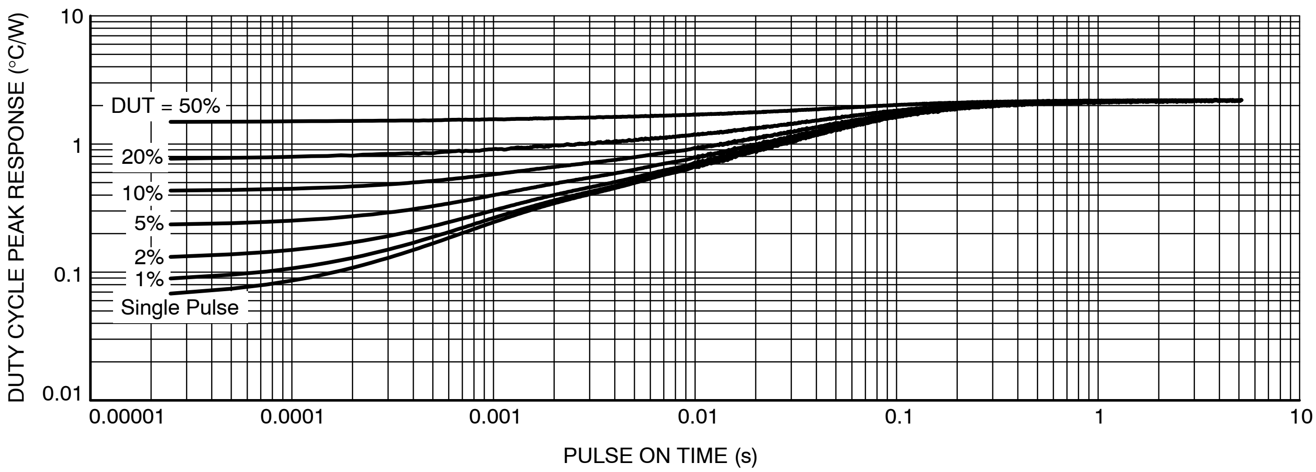


Figure 7. Transient Thermal Impedance (Half Bridge Diode)

TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT AND DIODE

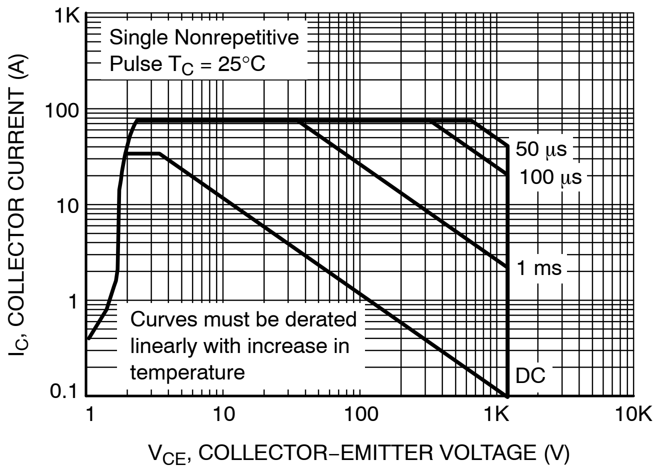


Figure 8. FBSOA

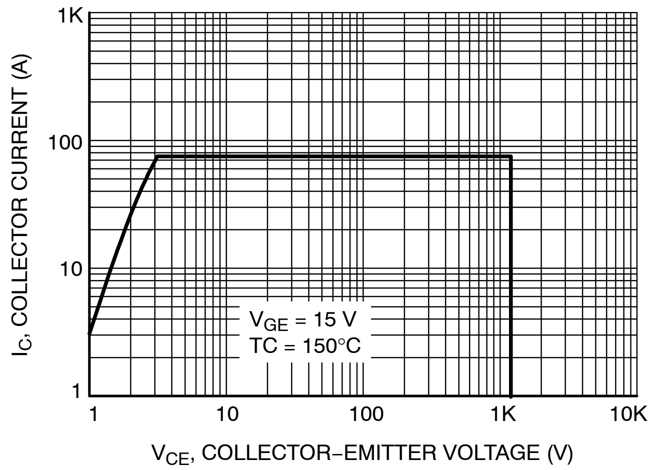


Figure 9. RBSOA

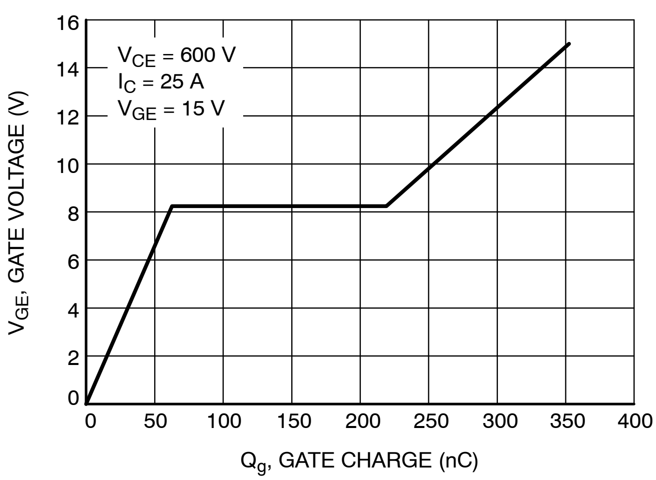


Figure 10. Gate Voltage vs. Gate Charge

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT AND DIODE

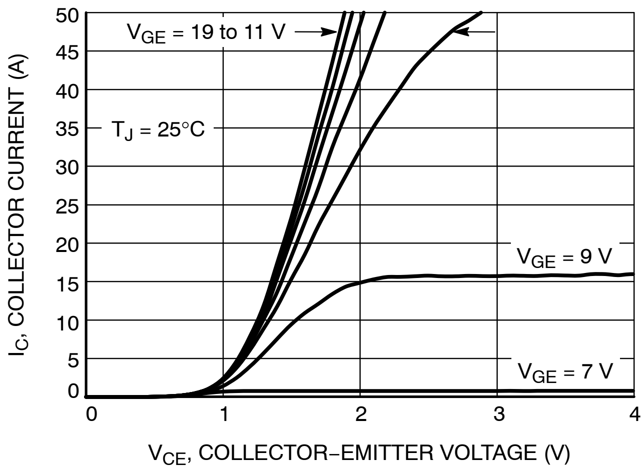


Figure 11. Typical Output Characteristics

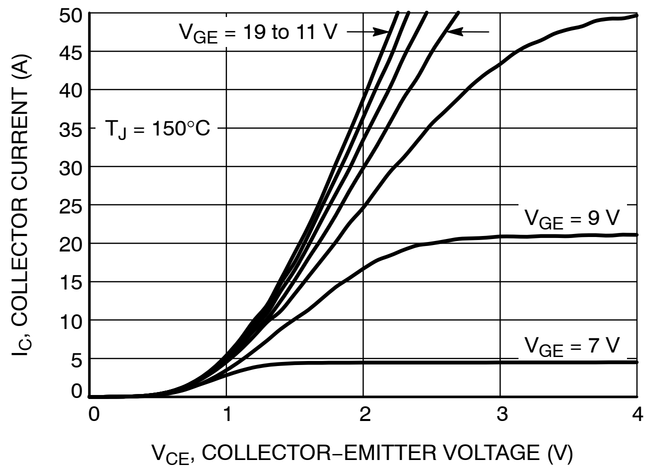


Figure 12. Typical Output Characteristics

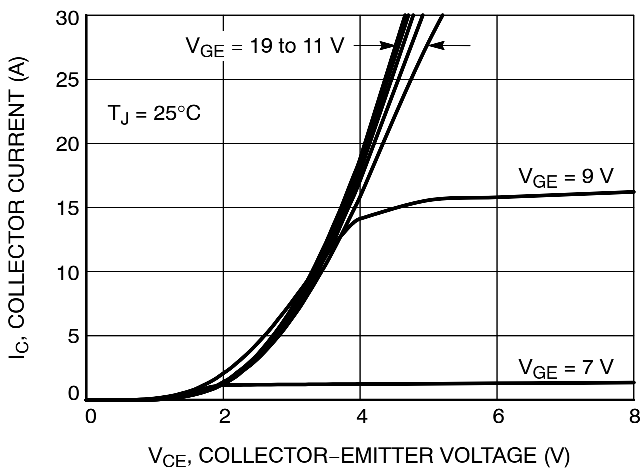


Figure 13. Typical Output Characteristics (I_C vs. V_{DT})

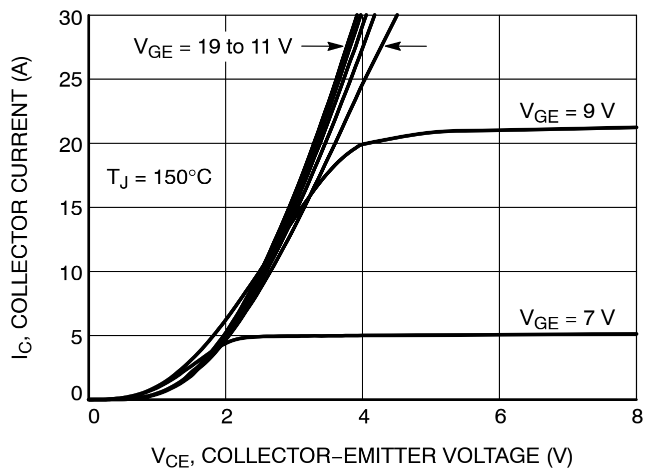


Figure 14. Typical Output Characteristics (I_C vs. V_{DT})

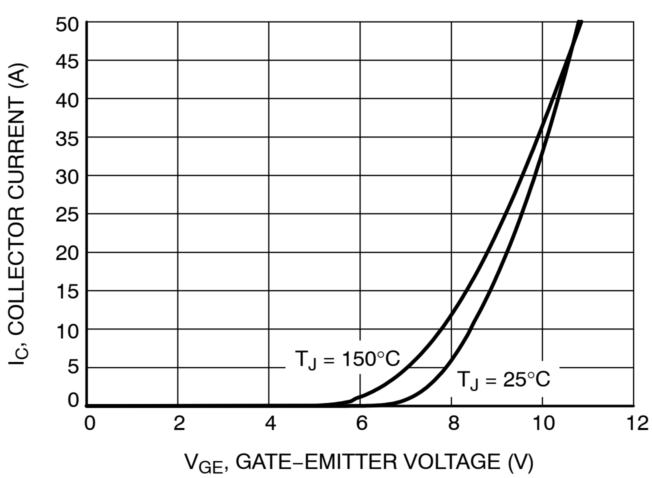


Figure 15. Typical Transfer Characteristics

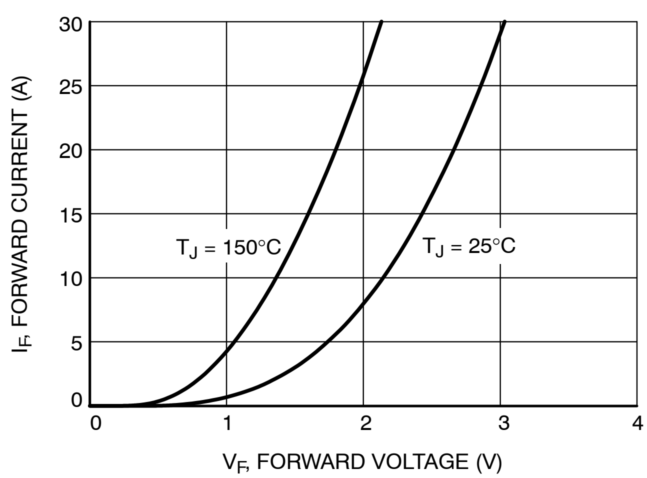


Figure 16. Diode Forward Characteristics

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT AND DIODE

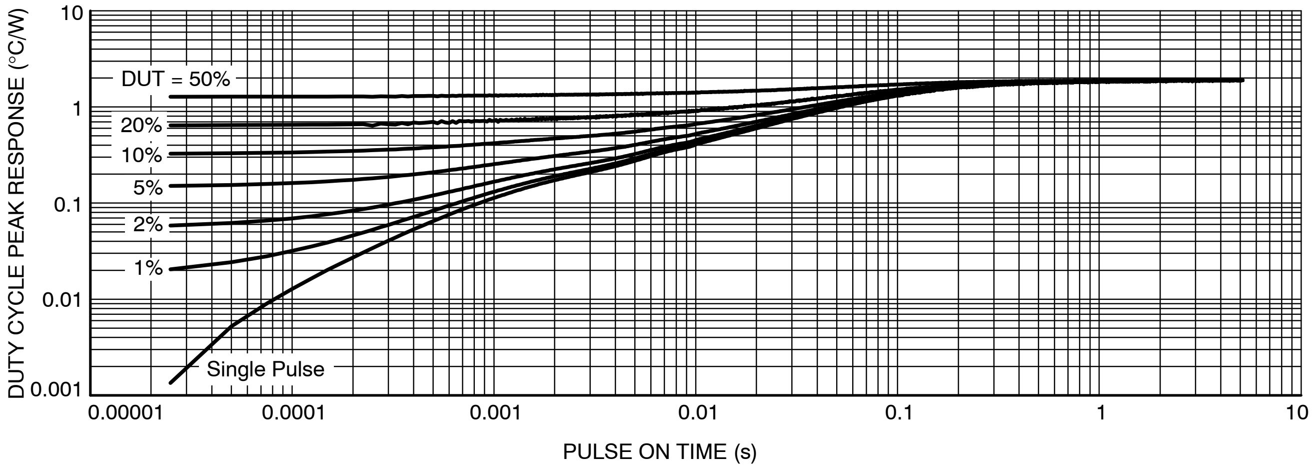


Figure 17. Transient Thermal Impedance (Neutral Point IGBT)

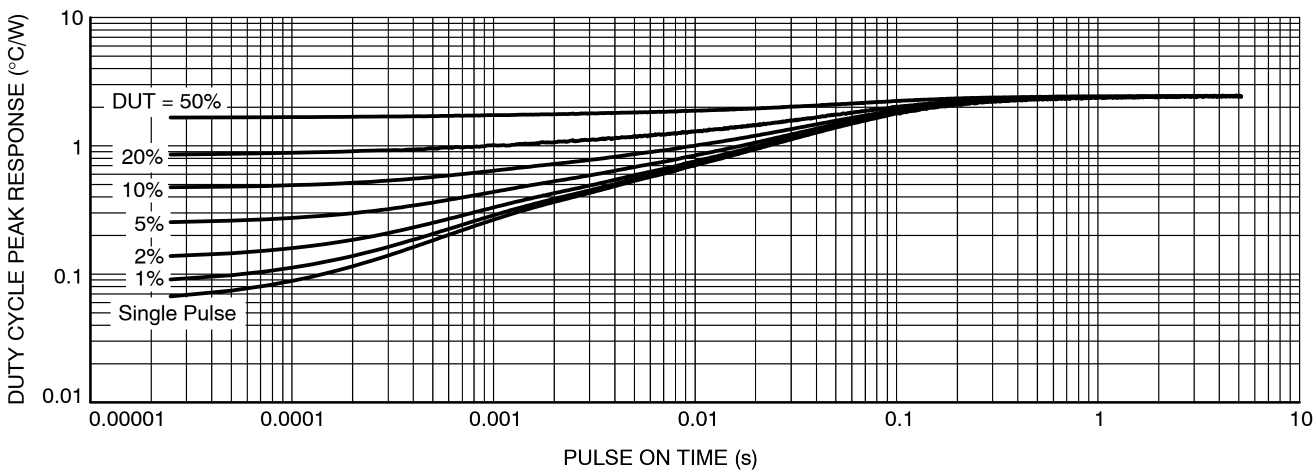


Figure 18. Transient Thermal Impedance (Neutral Point Diode)

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT AND DIODE

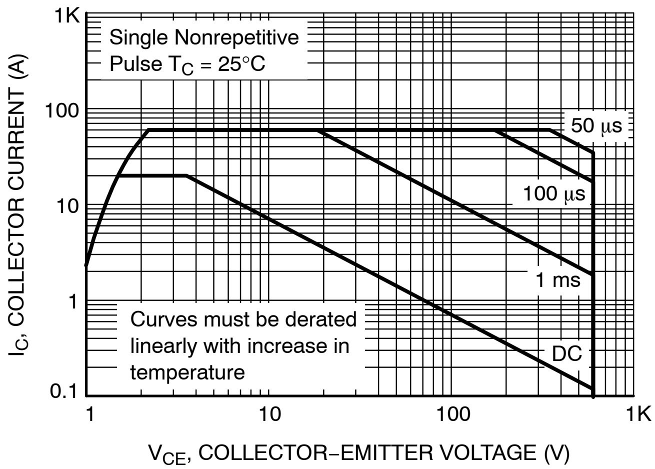


Figure 19. FBSOA

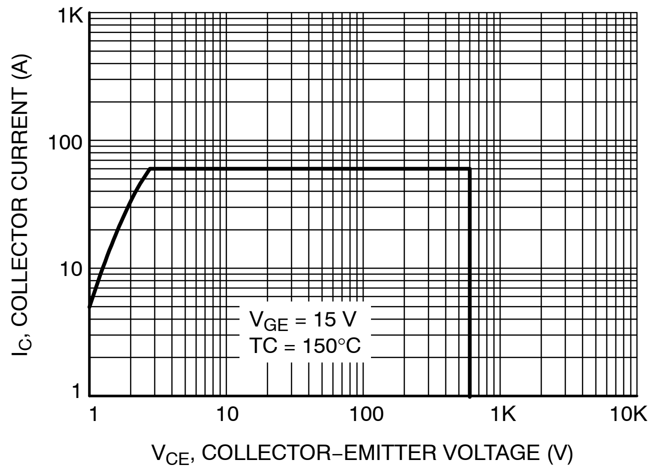


Figure 20. RBSOA

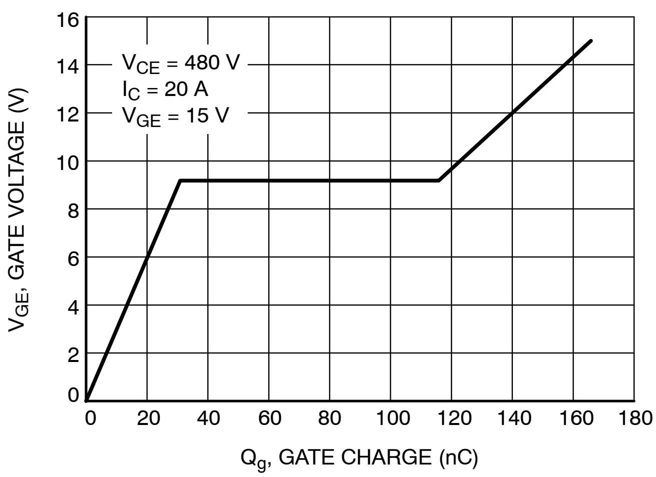


Figure 21. Gate Voltage vs. Gate Charge

TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT COMUTATES NEUTRAL POINT DIODE

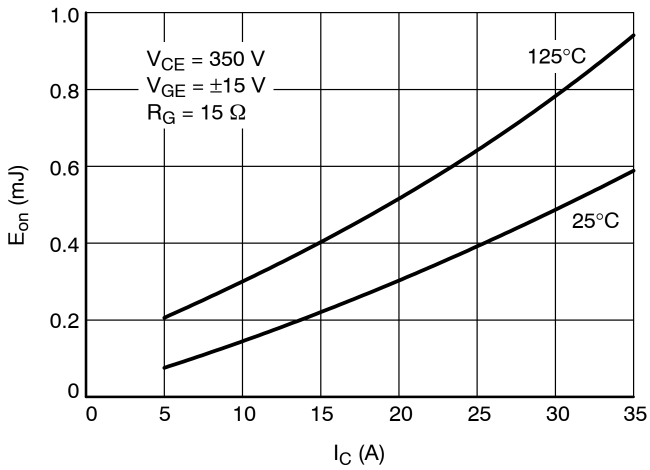


Figure 22. Typical Switching Loss E_{on} vs. I_C

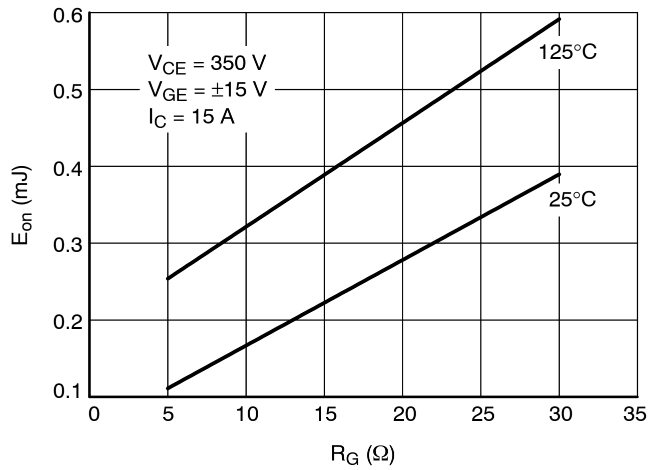


Figure 23. Typical Switching Loss E_{on} vs. R_G

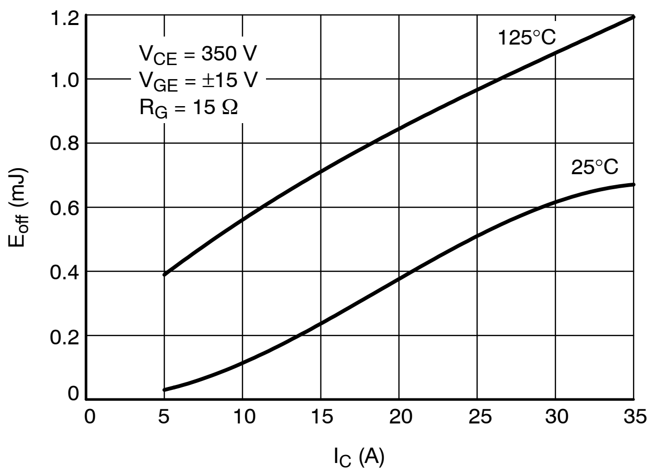


Figure 24. Typical Switching Loss E_{off} vs. I_C

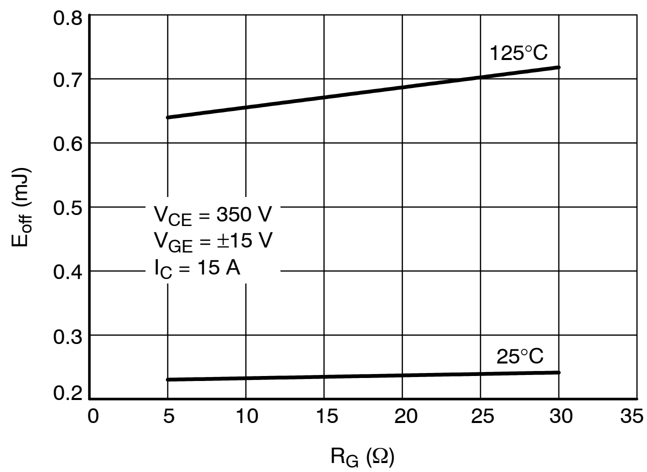


Figure 25. Typical Switching Loss E_{off} vs. R_G

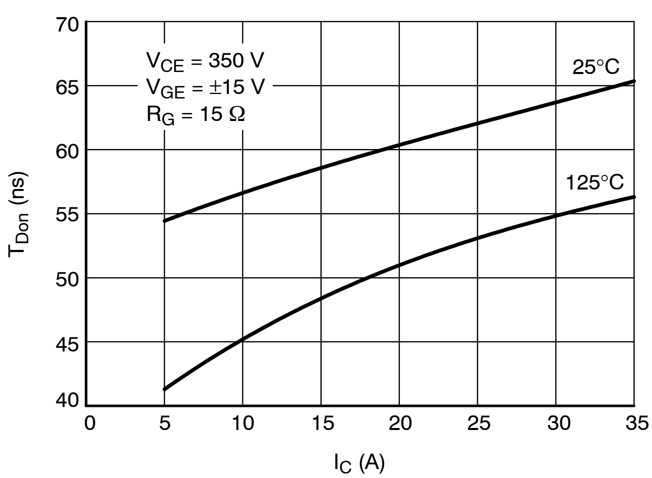


Figure 26. Typical Switching Time T_{Don} vs. I_C

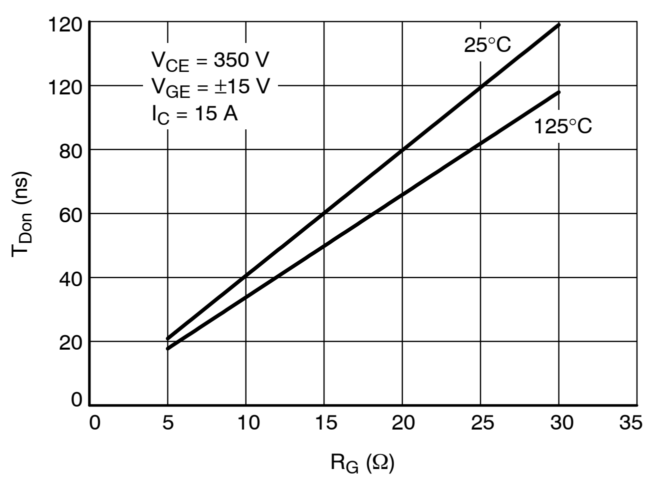


Figure 27. Typical Switching Time T_{Don} vs. R_G

TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT COMUTATES NEUTRAL POINT DIODE

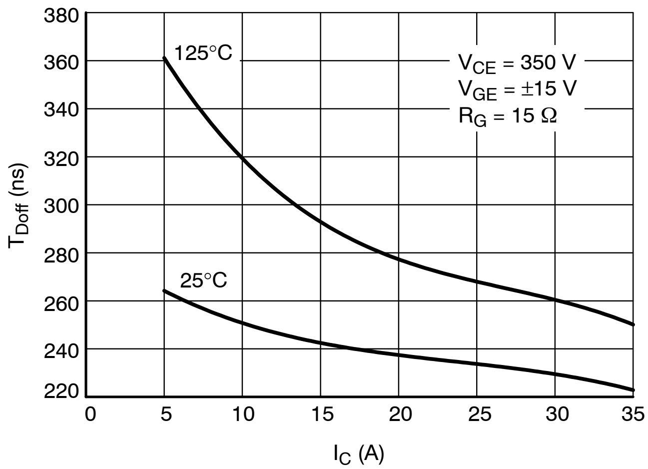


Figure 28. Typical Switching Time T_{Doff} vs. I_C

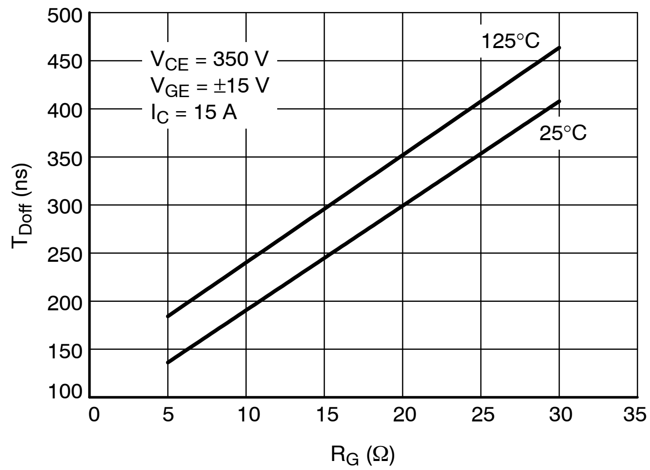


Figure 29. Typical Switching Time T_{Doff} vs. R_G

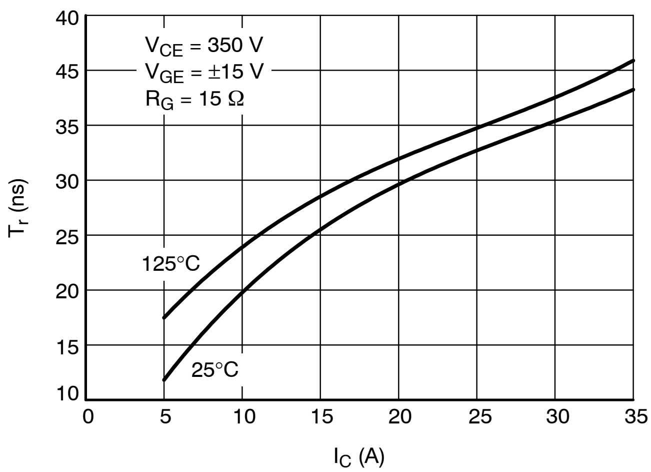


Figure 30. Typical Switching Time T_r vs. I_C

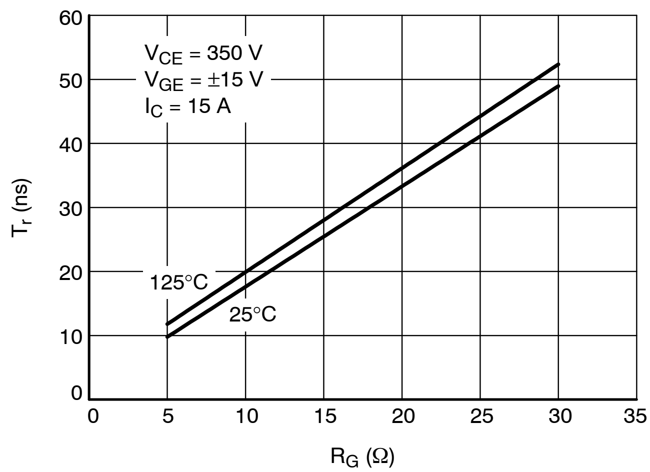


Figure 31. Typical Switching Time T_r vs. R_G

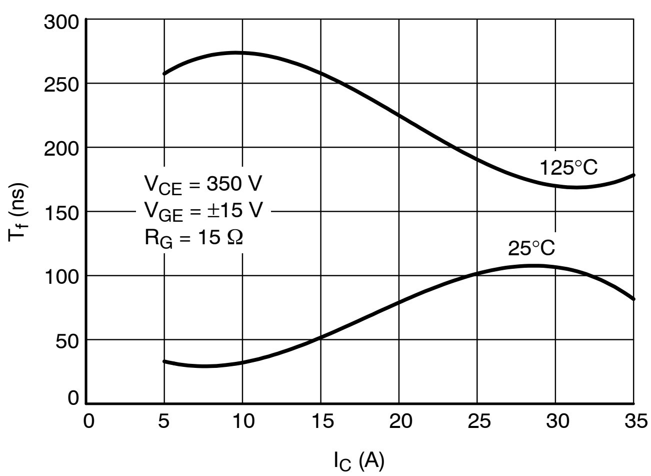


Figure 32. Typical Switching Time T_f vs. I_C

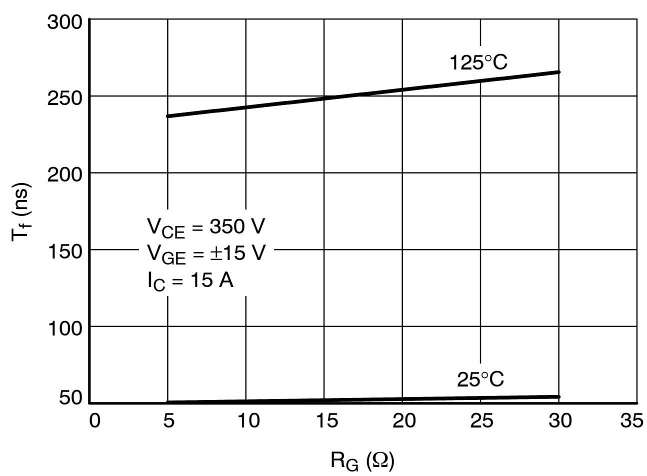


Figure 33. Typical Switching Time T_f vs. R_G

TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT COMUTATES NEUTRAL POINT DIODE

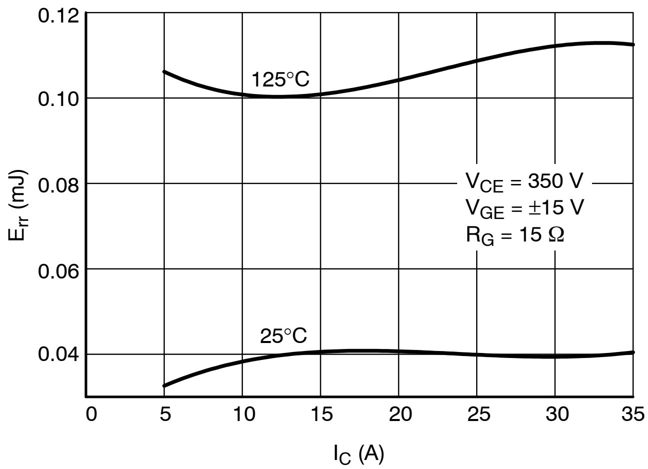


Figure 34. Typical Reverse Recovery Energy vs. I_C

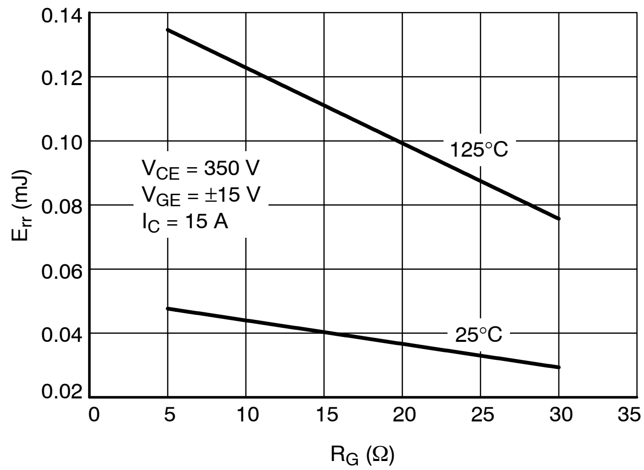


Figure 35. Typical Reverse Recovery Energy vs. R_G

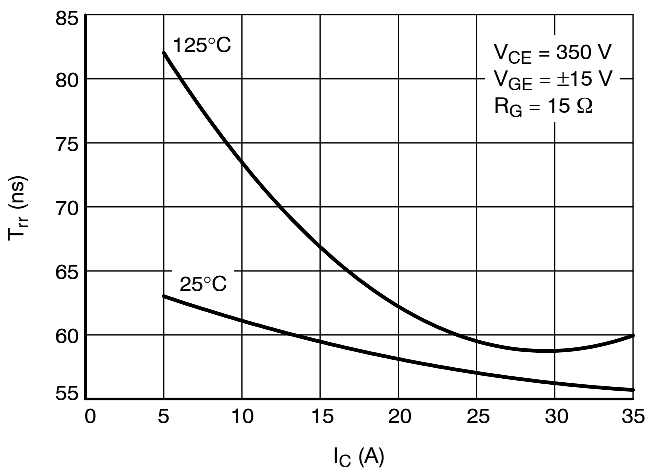


Figure 36. Typical Reverse Recovery Time vs. I_C

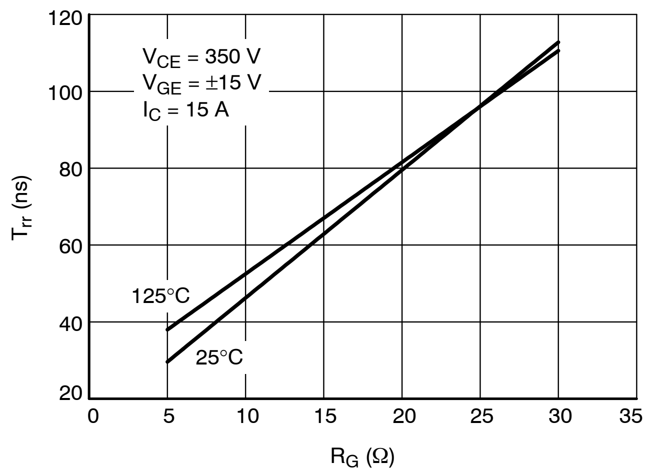


Figure 37. Typical Reverse Recovery Time vs. R_G

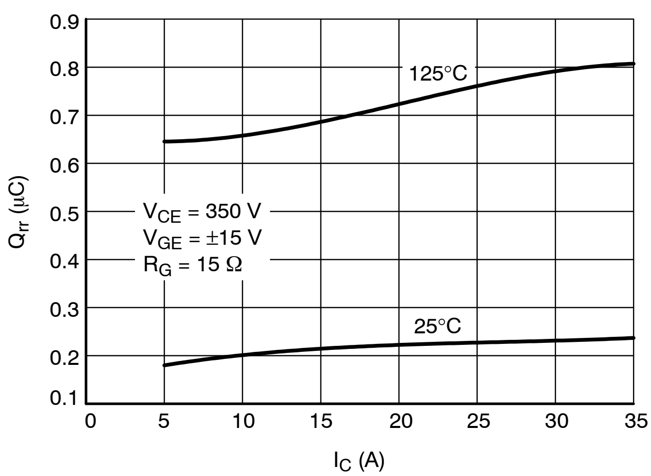


Figure 38. Typical Reverse Recovery Charge vs. I_C

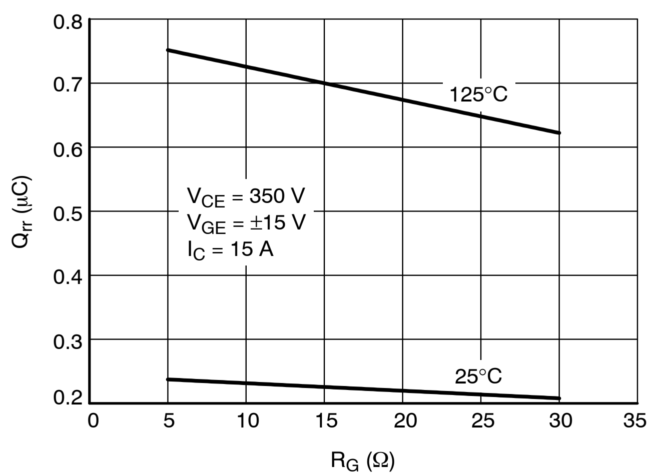


Figure 39. Typical Reverse Recovery Charge vs. R_G

TYPICAL CHARACTERISTICS – HALF BRIDGE IGBT COMUTATES NEUTRAL POINT DIODE

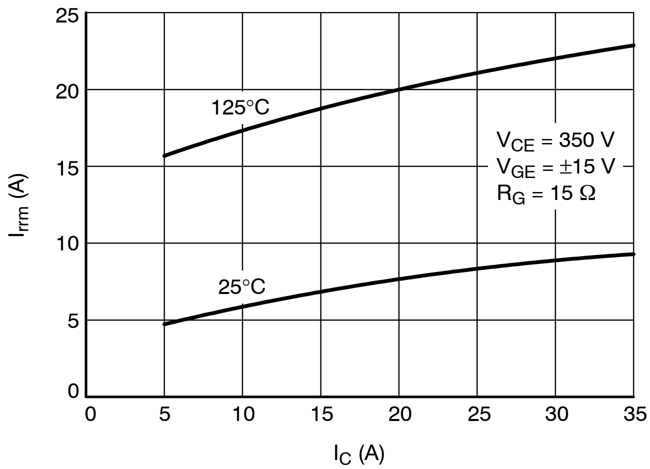


Figure 40. Typical Reverse Recovery Current vs. I_C

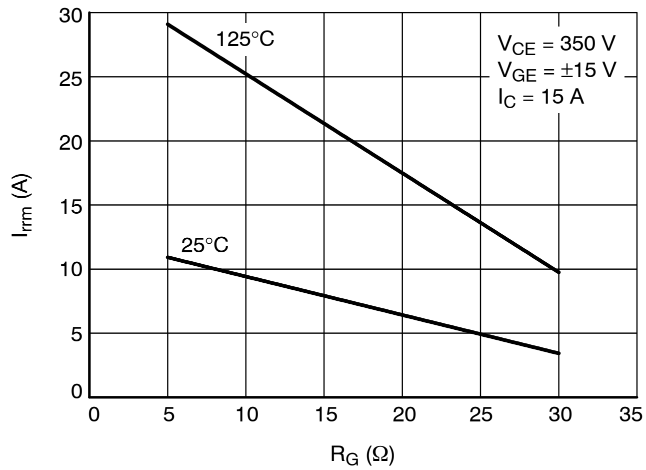


Figure 41. Typical Reverse Recovery Current vs. R_G

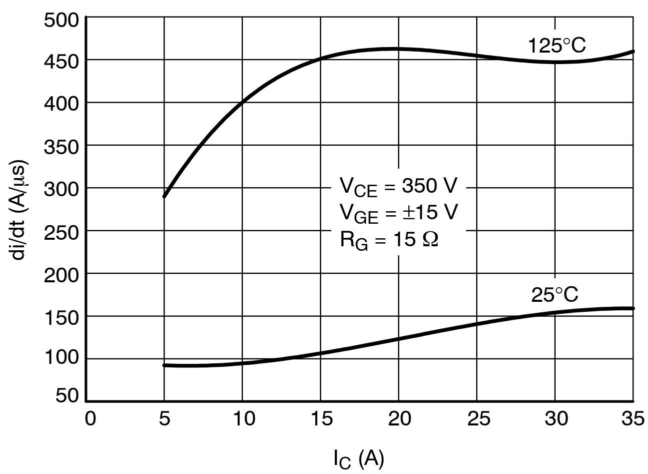


Figure 42. Typical di/dt vs. I_C

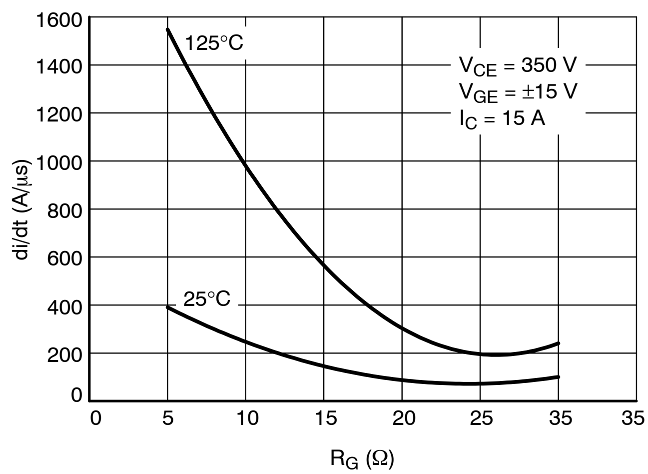


Figure 43. Typical di/dt vs. R_G

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT COMUTATES HALF BRIDGE DIODE

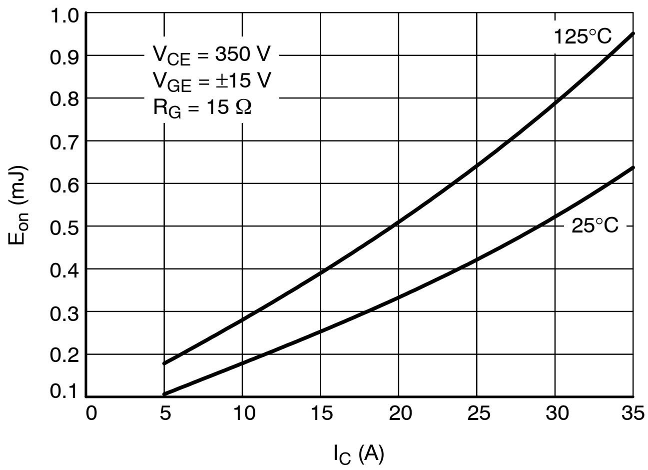


Figure 44. Typical Switching Energy E_{on} vs. I_C

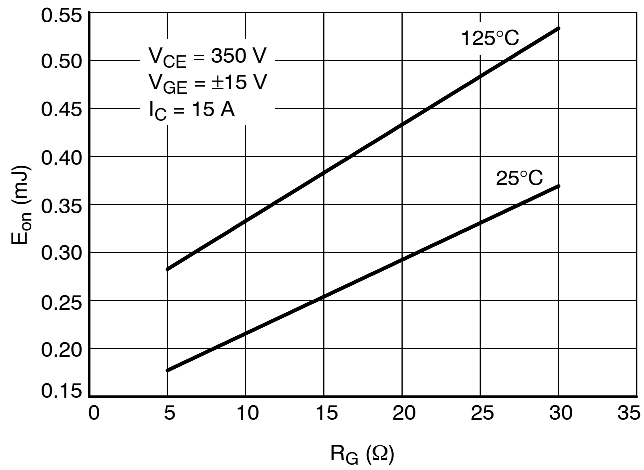


Figure 45. Typical Switching Energy E_{on} vs. R_G

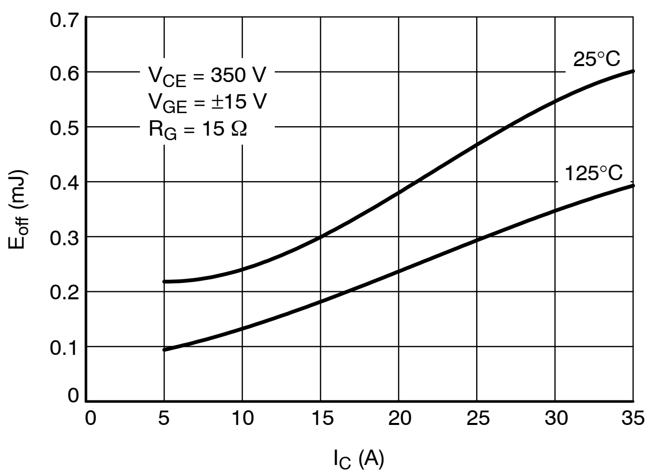


Figure 46. Typical Switching Energy E_{off} vs. I_C

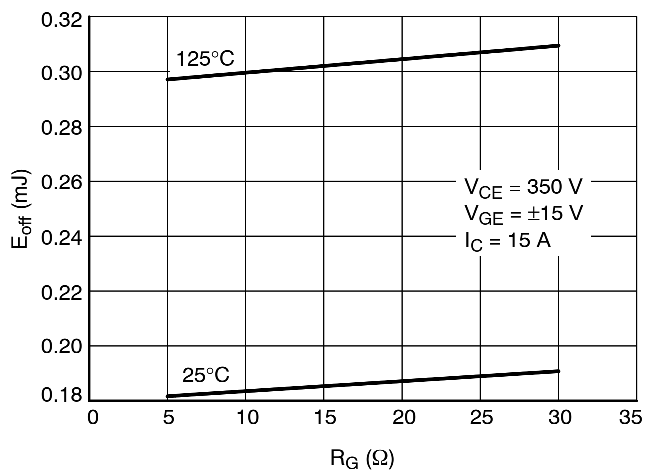


Figure 47. Typical Switching Energy E_{off} vs. R_G

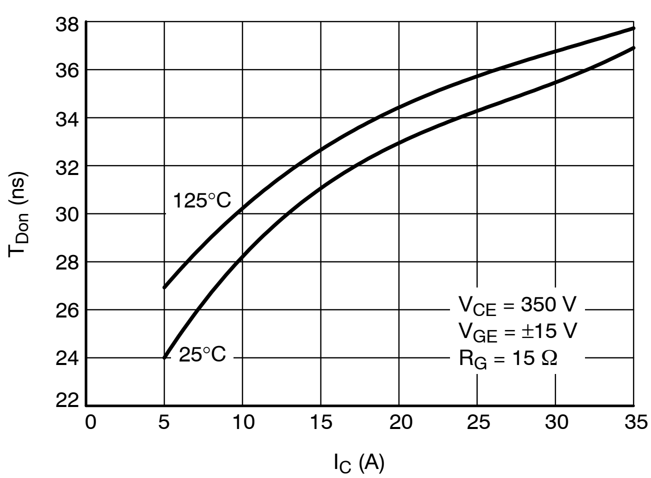


Figure 48. Typical Switching Time T_{Don} vs. I_C

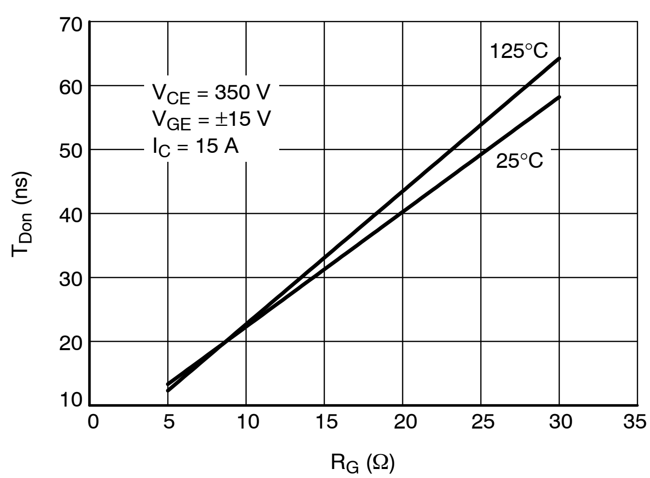


Figure 49. Typical Switching Time T_{Don} vs. R_G

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT COMUTATES HALF BRIDGE DIODE

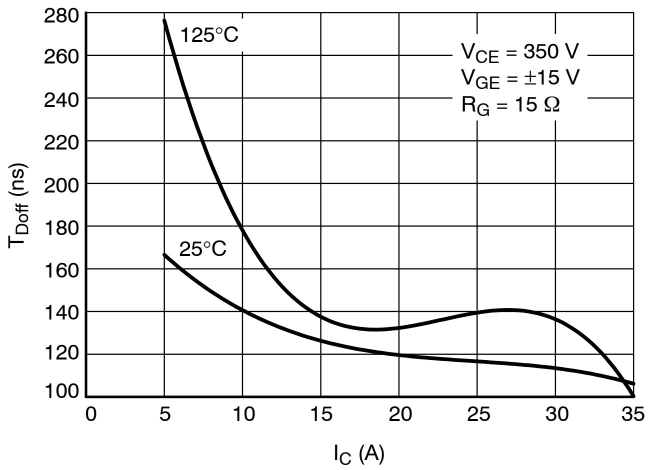


Figure 50. Typical Switching Time T_{Doff} vs. I_C

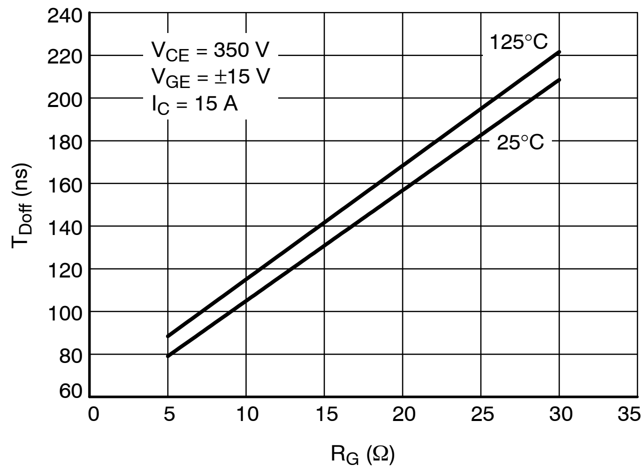


Figure 51. Typical Switching Time T_{Doff} vs. R_G

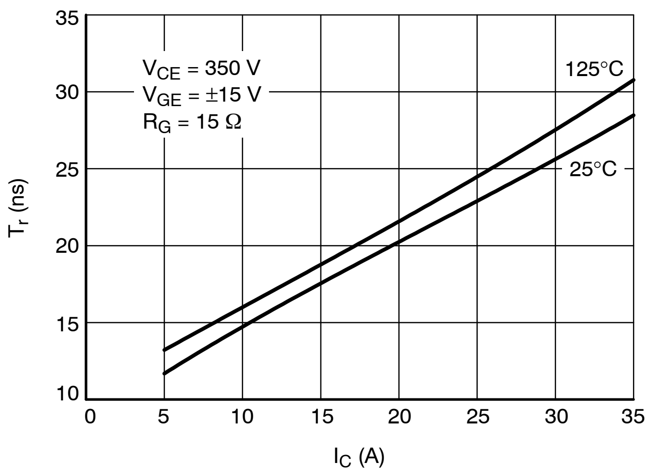


Figure 52. Typical Switching Time T_r vs. I_C

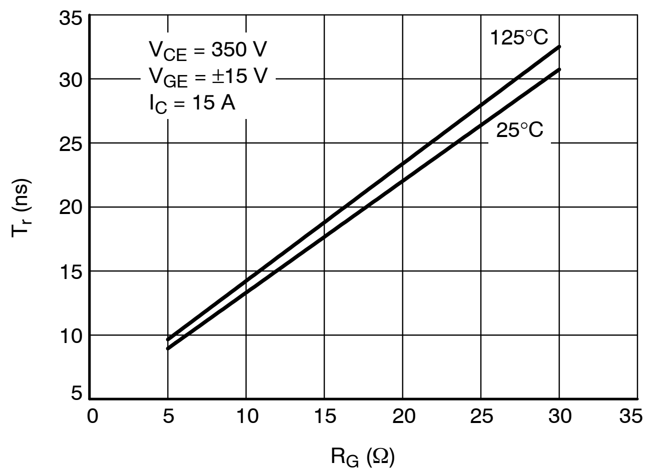


Figure 53. Typical Switching Time T_r vs. R_G

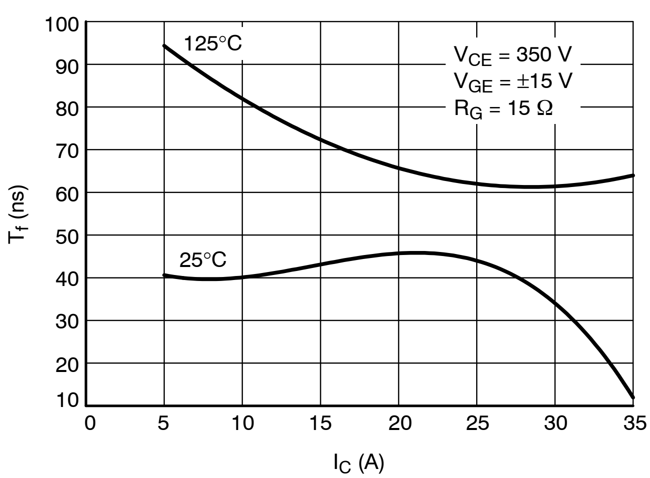


Figure 54. Typical Switching Time T_f vs. I_C

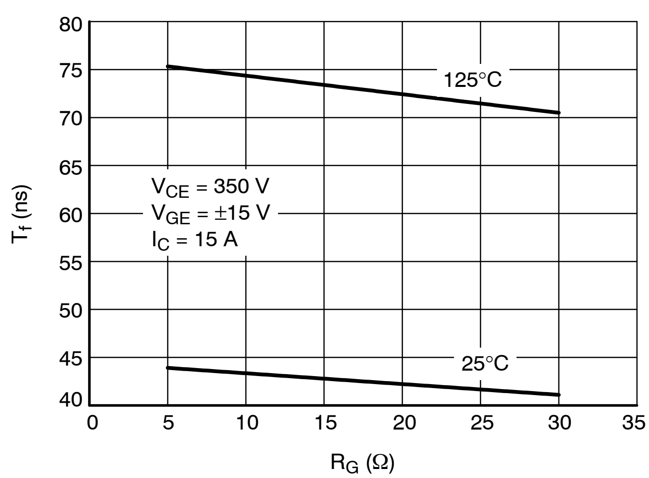


Figure 55. Typical Switching Time T_f vs. R_G

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT COMUTATES HALF BRIDGE DIODE

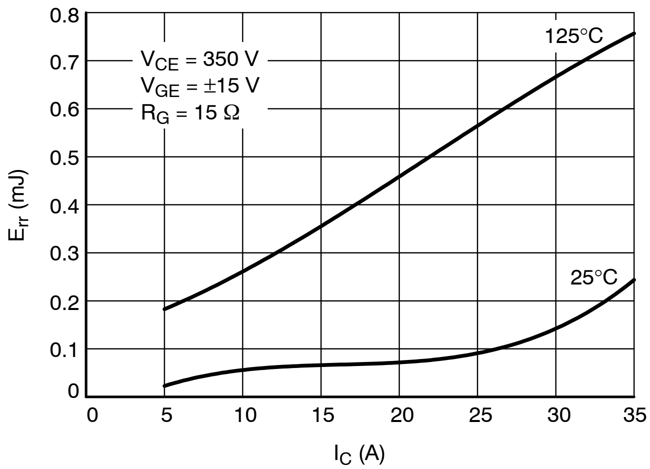


Figure 56. Typical Reverse Recovery Energy vs. I_C

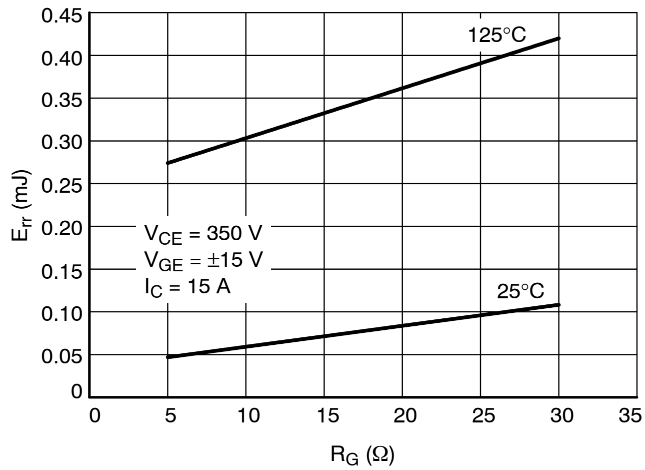


Figure 57. Typical Reverse Recovery Energy vs. R_G

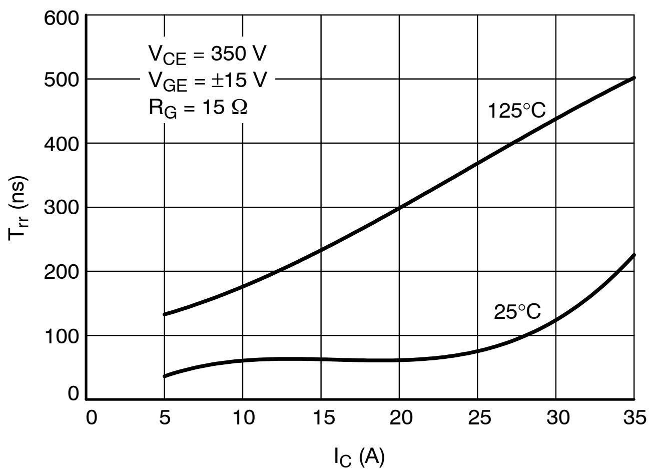


Figure 58. Typical Reverse Recovery Time vs. I_C

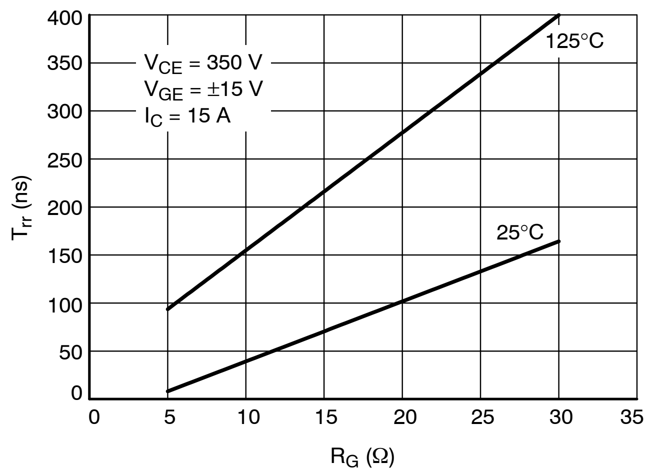


Figure 59. Typical Reverse Recovery Time vs. R_G

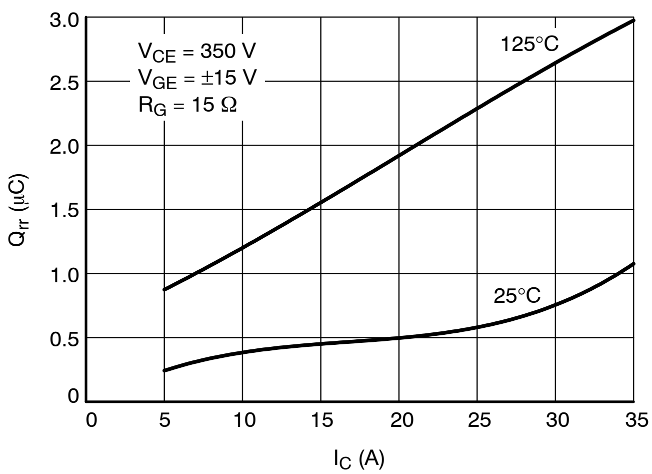


Figure 60. Typical Reverse Recovery Charge vs. I_C

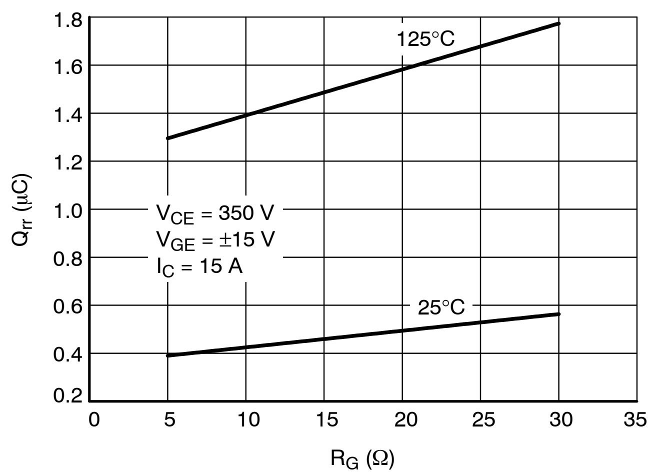


Figure 61. Typical Reverse Recovery Charge vs. R_G

TYPICAL CHARACTERISTICS – NEUTRAL POINT IGBT COMUTATES HALF BRIDGE DIODE

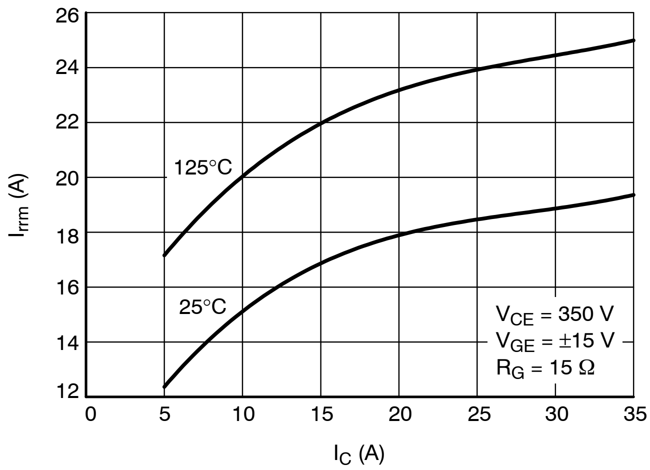


Figure 62. Typical Reverse Recovery Current vs. I_C

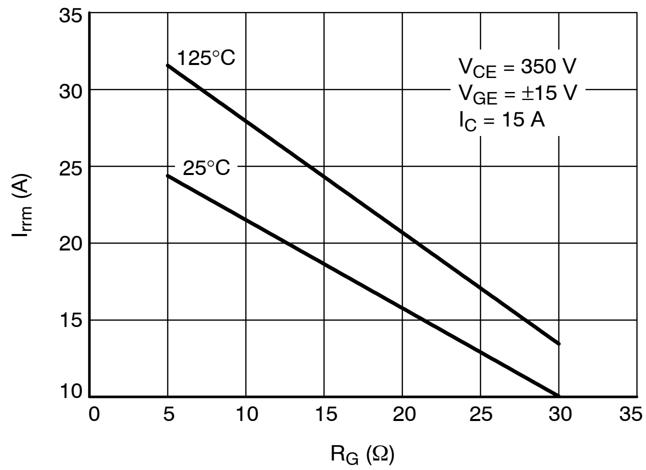


Figure 63. Typical Reverse Recovery Current vs. R_G

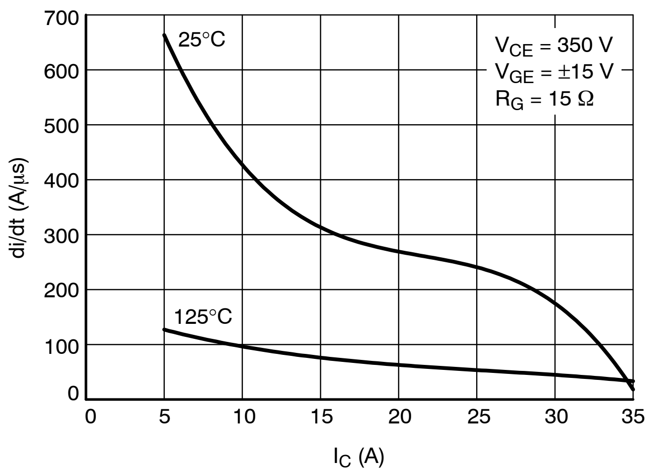


Figure 64. Typical di/dt vs. I_C

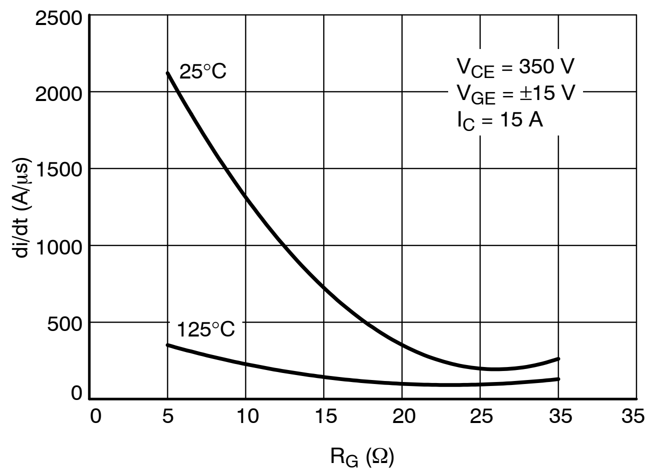


Figure 65. Typical di/dt vs. R_G

PIM44, 71x37.4 (PRESSFIT PINS)

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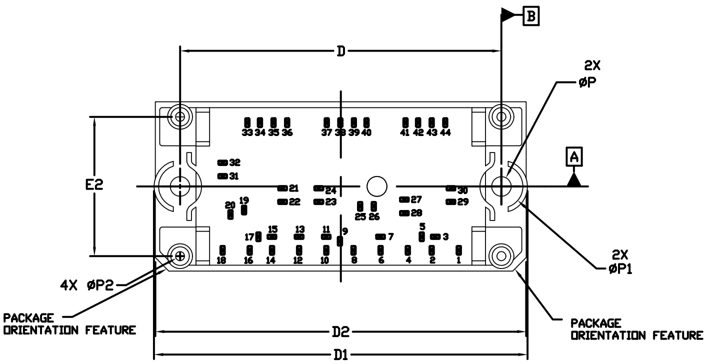
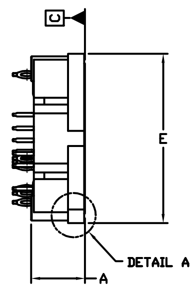
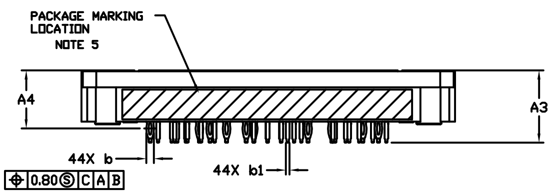


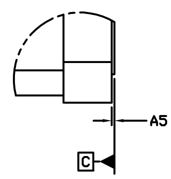
TOP VIEW



END VIEW



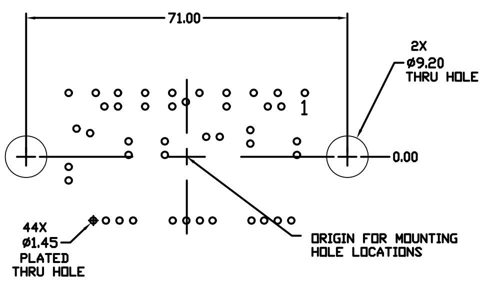
SIDE VIEW



DETAIL A

PIN	PIN POSITION X	PIN POSITION Y	PIN	PIN POSITION X	PIN POSITION Y
1	26.10	14.10	23	−4.85	3.40
2	20.10	14.10	24	−4.85	0.40
3	20.90	11.10	25	4.30	4.40
4	14.80	14.10	26	7.30	4.40
5	17.90	11.10	27	14.05	2.90
6	8.80	14.10	28	14.05	5.90
7	8.80	11.10	29	24.35	3.40
8	2.80	14.10	30	24.35	0.40
9	−0.20	12.10	31	−26.10	−2.25
10	−3.20	14.10	32	−26.10	−5.25
11	−3.20	11.10	33	−20.65	−14.10
12	−9.20	14.10	34	−17.85	−14.10
13	−9.20	11.10	35	−14.85	−14.10
14	−15.20	14.10	36	−11.85	−14.10
15	−15.20	11.10	37	−3.10	−14.10
16	−20.10	14.10	38	−0.10	−14.10
17	−18.20	11.10	39	2.90	−14.10
18	−26.10	14.10	40	5.70	−14.10
19	−21.35	5.20	41	14.30	−14.10
20	−24.35	6.20	42	17.10	−14.10
21	−12.85	0.40	43	20.10	−14.10
22	−12.85	3.40	44	23.10	−14.10

NOTE 4



RECOMMENDED
MOUNTING PATTERN

DIM	MILLIMETERS MIN.	NOM.	MAX.
A	11.50	12.00	12.50
A3	15.50	16.00	16.50
A4		12.83 BSC	
A5	0.10	0.20	0.30
b	1.61	1.66	1.71
b1	0.75	0.80	0.85
D	70.50	71.00	71.50
D1	82.00	82.50	83.00
D2	81.50	82.00	82.50
E	36.90	37.40	37.90
E2	30.30	30.80	31.30
P	4.10	4.30	4.50
P1	9.30	9.50	9.70
P2	1.80	2.00	2.20

PIN	PIN POSITION X	PIN POSITION Y	PIN	PIN POSITION X	PIN POSITION Y
1	26.10	−14.10	23	−4.85	−3.40
2	20.10	−14.10	24	−4.85	−0.40
3	20.90	−11.10	25	4.30	−4.40
4	14.80	−14.10	26	7.30	−4.40
5	17.90	−11.10	27	14.05	−2.90
6	8.80	−14.10	28	14.05	−5.90
7	8.80	−11.10	29	24.35	−3.40
8	2.80	−14.10	30	24.35	−0.40
9	−0.20	−12.10	31	−26.10	2.25
10	−3.20	−14.10	32	−26.10	5.25
11	−3.20	−11.10	33	−20.65	14.10
12	−9.20	−14.10	34	−17.85	14.10
13	−9.20	−11.10	35	−14.85	14.10
14	−15.20	−14.10	36	−11.85	14.10
15	−15.20	−11.10	37	−3.10	14.10
16	−20.10	−14.10	38	−0.10	14.10
17	−18.20	−11.10	39	2.90	14.10
18	−26.10	−14.10	40	5.70	14.10
19	−21.35	−5.20	41	14.30	14.10
20	−24.35	−6.20	42	17.10	14.10
21	−12.85	−0.40	43	20.10	14.10
22	−12.85	−3.40	44	23.10	14.10

NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
2. CONTROLLING DIMENSION: MILLIMETERS
3. DIMENSIONS b AND b1 APPLY TO THE PLATED TERMINALS AND ARE MEASURED AT DIMENSION A4.
4. POSITION OF THE CENTER OF THE TERMINALS IS DETERMINED FROM DATUM B THE CENTER OF DIMENSION D, X DIRECTION, AND FROM DATUM A, Y DIRECTION. POSITIONAL TOLERANCE, AS NOTED IN DRAWING, APPLIES TO EACH TERMINAL IN BOTH DIRECTIONS.
5. PACKAGE MARKING IS LOCATED AS SHOWN ON THE SIDE OPPOSITE THE PACKAGE ORIENTATION FEATURES.

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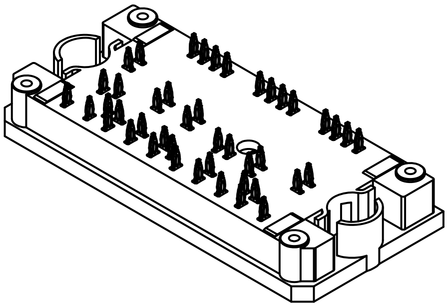
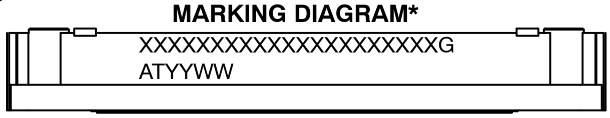


PIM44, 71x37.4
CASE 180AS
ISSUE O

DATE 15 JUN 2018

GENERIC
MARKING DIAGRAM*



XXXXX = Specific Device Code
G = Pb−Free Package
AT = Assembly & Test Site Code
YYWW = Year and Work Week Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, “G” or microdot “ ▪”, may or may not be present. Some products may not follow the Generic Marking.

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DESCRIPTION:	PIM44, 71x37.4	PAGE 2 OF 2

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